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Understanding [Embedded - CPLDs \(Complex Programmable Logic Devices\)](#)

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

Applications of Embedded - CPLDs

Details

Product Status	Obsolete
Programmable Type	In-System Reprogrammable™ (ISR™) CMOS
Delay Time tpd(1) Max	10 ns
Voltage Supply - Internal	4.75V ~ 5.25V
Number of Logic Elements/Blocks	-
Number of Macrocells	64
Number of Gates	-
Number of I/O	37
Operating Temperature	0°C ~ 70°C (TA)
Mounting Type	Surface Mount
Package / Case	44-LQFP
Supplier Device Package	44-TQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/cy37064p44-125axc

Speed Bins

Device	200	167	154	143	125	100	83	66
CY37032V				X		X		
CY37064V				X		X		
CY37128V					X		X	
CY37192V						X		X
CY37256V						X		X
CY37384V							X	X
CY37512V							X	X

Device-Package Offering and I/O Count

Device	44-Lead TQFP	44-Lead CLCC	48-Lead FBGA	84-Lead CLCC	100-Lead TQFP	100-Lead FBGA	160-Lead TQFP	160-Lead CQFP	208-Lead PQFP	208-Lead CQFP	292-Lead PBGA	256-Lead FBGA	388-Lead PBGA	400-Lead FBGA
CY37032V	37		37											
CY37064V	37	37	37		69	69								
CY37128V				69	69	85	133							
CY37192V							125							
CY37256V							133	133	165		197	197		
CY37384V									165		197			
CY37512V									165	165	197		269	269

Architecture Overview of Ultra37000 Family

Programmable Interconnect Matrix

The PIM consists of a completely global routing matrix for signals from I/O pins and feedbacks from the logic blocks. The PIM provides extremely robust interconnection to avoid fitting and density limitations.

The inputs to the PIM consist of all I/O and dedicated input pins and all macrocell feedbacks from within the logic blocks. The number of PIM inputs increases with pin count and the number of logic blocks. The outputs from the PIM are signals routed to the appropriate logic blocks. Each logic block receives 36 inputs from the PIM and their complements, allowing for 32-bit operations to be implemented in a single pass through the device. The wide number of inputs to the logic block also improves the routing capacity of the Ultra37000 family.

An important feature of the PIM is its simple timing. The propagation delay through the PIM is accounted for in the timing specifications for each device. There is no additional delay for traveling through the PIM. In fact, all inputs travel through the PIM. As a result, there are no route-dependent timing parameters on the Ultra37000 devices. The worst-case PIM delays are incorporated in all appropriate Ultra37000 specifications.

Routing signals through the PIM is completely invisible to the user. All routing is accomplished by software—no hand routing is necessary. *Warp*® and third-party development packages automatically route designs for the Ultra37000 family in a matter of minutes. Finally, the rich routing resources of the Ultra37000 family accommodate last minute logic changes while maintaining fixed pin assignments.

Logic Block

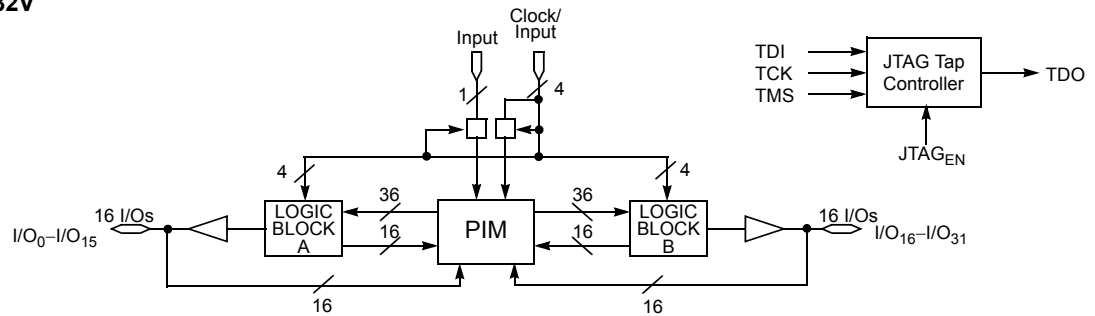
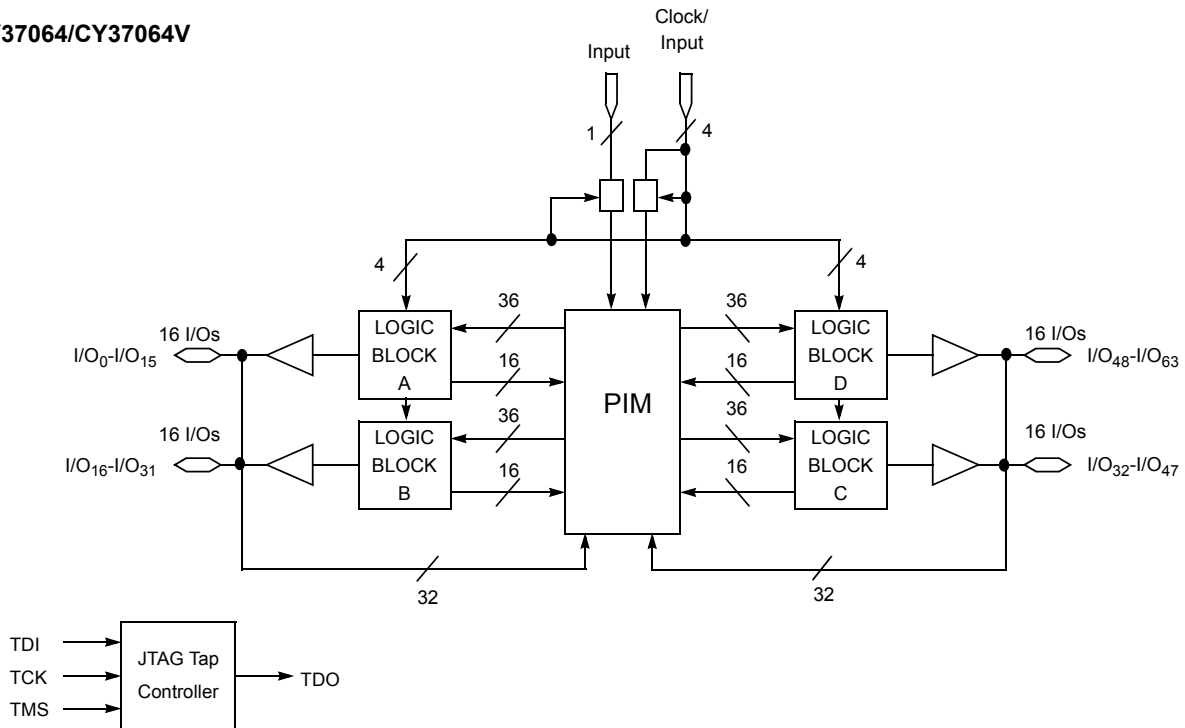
The logic block is the basic building block of the Ultra37000 architecture. It consists of a product term array, an intelligent product-term allocator, 16 macrocells, and a number of I/O cells. The number of I/O cells varies depending on the device used. Refer to *Figure 1* for the block diagram.

Product Term Array

Each logic block features a 72 x 87 programmable product term array. This array accepts 36 inputs from the PIM, which originate from macrocell feedbacks and device pins. Active LOW and active HIGH versions of each of these inputs are generated to create the full 72-input field. The 87 product terms in the array can be created from any of the 72 inputs.

Of the 87 product terms, 80 are for general-purpose use for the 16 macrocells in the logic block. Four of the remaining seven product terms in the logic block are output enable (OE) product terms. Each of the OE product terms controls up to eight of the 16 macrocells and is selectable on an individual macrocell basis. In other words, each I/O cell can select between one of two OE product terms to control the output buffer. The first two of these four OE product terms are available to the upper half of the I/O macrocells in a logic block. The other two OE product terms are available to the lower half of the I/O macrocells in a logic block.

The next two product terms in each logic block are dedicated asynchronous set and asynchronous reset product terms. The final product term is the product term clock. The set, reset, OE and product term clock have polarity control to realize OR functions in a single pass through the array.

Logic Block Diagrams
CY37032/CY37032V

CY37064/CY37064V


5.0V Device Characteristics

Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature -65°C to +150°C

Ambient Temperature with

Power Applied -55°C to +125°C

Supply Voltage to Ground Potential -0.5V to +7.0V

DC Voltage Applied to Outputs

in High-Z State -0.5V to +7.0V

DC Input Voltage -0.5V to +7.0V

DC Program Voltage 4.5 to 5.5V

Current into Outputs 16 mA

Static Discharge Voltage > 2001V
(per MIL-STD-883, Method 3015)

Latch-up Current > 200 mA

Operating Range^[2]

Range	Ambient Temperature ^[2]	Junction Temperature	Output Condition	V _{CC}	V _{CCO}
Commercial	0°C to +70°C	0°C to +90°C	5V	5V ± 0.25V	5V ± 0.25V
			3.3V	5V ± 0.25V	3.3V ± 0.3V
Industrial	-40°C to +85°C	-40°C to +105°C	5V	5V ± 0.5V	5V ± 0.5V
			3.3V	5V ± 0.5V	3.3V ± 0.3V
Military ^[3]	-55°C to +125°C	-55°C to +130°C	5V	5V ± 0.5V	5V ± 0.5V
			3.3V	5V ± 0.5V	3.3V ± 0.3V

5.0V Device Electrical Characteristics Over the Operating Range

Parameter	Description	Test Conditions	Min.	Typ.	Max.	Unit
V _{OH}	Output HIGH Voltage	V _{CC} = Min. I _{OH} = -3.2 mA (Com'I/Ind) ^[4] I _{OH} = -2.0 mA (Mil) ^[4]	2.4 2.4			V
V _{OHZ}	Output HIGH Voltage with Output Disabled ^[5]	V _{CC} = Max. I _{OH} = 0 μA (Com'I) ^[6] I _{OH} = 0 μA (Ind/Mil) ^[6] I _{OH} = -100 μA (Com'I) ^[6] I _{OH} = -150 μA (Ind/Mil) ^[6]			4.2 4.5 3.6 3.6	V
V _{OL}	Output LOW Voltage	V _{CC} = Min. I _{OL} = 16 mA (Com'I/Ind) ^[4] I _{OL} = 12 mA (Mil) ^[4]			0.5 0.5	V
V _{IH}	Input HIGH Voltage	Guaranteed Input Logical HIGH Voltage for all Inputs ^[7]	2.0		V _{CCmax}	V
V _{IL}	Input LOW Voltage	Guaranteed Input Logical LOW Voltage for all Inputs ^[7]	-0.5		0.8	V
I _{IX}	Input Load Current	V _I = GND OR V _{CC} , Bus-Hold Disabled	-10		10	μA
I _{OZ}	Output Leakage Current	V _O = GND or V _{CC} , Output Disabled, Bus-Hold Disabled	-50		50	μA
I _{OS}	Output Short Circuit Current ^[5, 8]	V _{CC} = Max., V _{OUT} = 0.5V	-30		-160	mA
I _{BHL}	Input Bus-Hold LOW Sustaining Current	V _{CC} = Min., V _{IL} = 0.8V	+75			μA
I _{BHH}	Input Bus-Hold HIGH Sustaining Current	V _{CC} = Min., V _{IH} = 2.0V	-75			μA
I _{BHLO}	Input Bus-Hold LOW Overdrive Current	V _{CC} = Max.			+500	μA
I _{BHHO}	Input Bus-Hold HIGH Overdrive Current	V _{CC} = Max.			-500	μA

Notes:

- Normal Programming Conditions apply across Ambient Temperature Range for specified programming methods. For more information on programming the Ultra37000 Family devices, please refer to the Application Note titled "An Introduction to In System Reprogramming with the Ultra37000."
- T_A is the "Instant On" case temperature.
- I_{OH} = -2 mA, I_{OL} = 2 mA for TDO.
- Tested initially and after any design or process changes that may affect these parameters.
- When the I/O is output disabled, the bus-hold circuit can weakly pull the I/O to above 3.6V if no leakage current is allowed. Note that all I/Os are output disabled during ISR programming. Refer to the application note "Understanding Bus-Hold" for additional information.
- These are absolute values with respect to device ground. All overshoots due to system or tester noise are included.
- Not more than one output should be tested at a time. Duration of the short circuit should not exceed 1 second. V_{OUT} = 0.5V has been chosen to avoid test problems caused by tester ground degradation.

Inductance^[5]

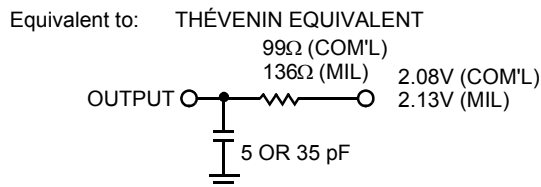
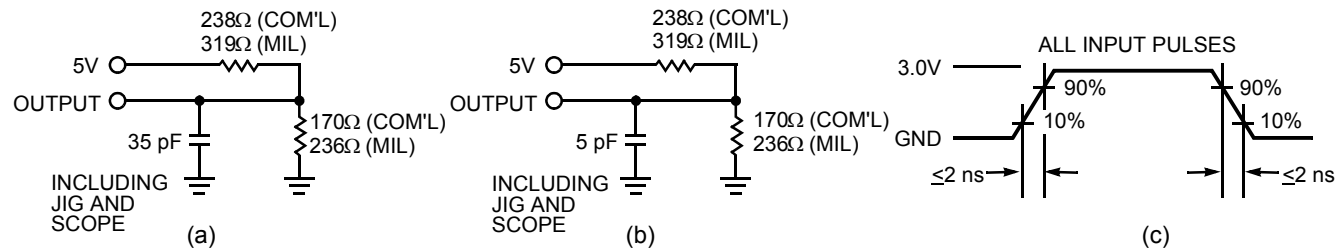
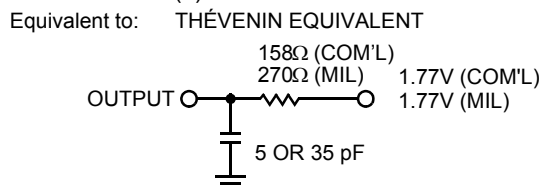
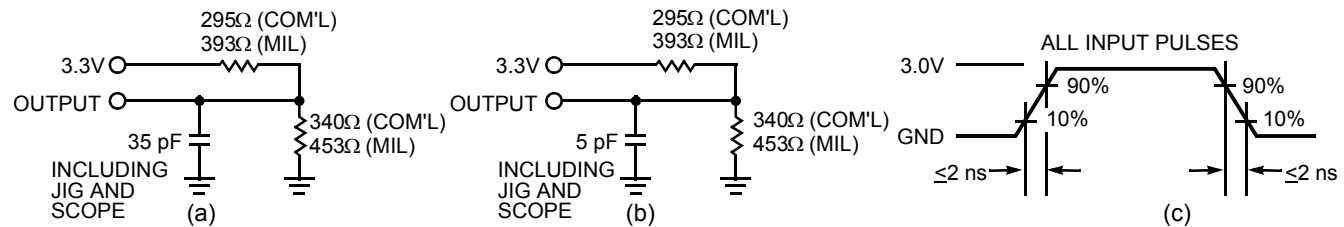
Parameter	Description	Test Conditions	44-Lead TQFP	44-Lead PLCC	44-Lead CLCC	84-Lead PLCC	84-Lead CLCC	100-Lead TQFP	160-Lead TQFP	208-Lead PQFP	Unit
L	Maximum Pin Inductance	$V_{IN} = 3.3V$ at $f = 1\text{ MHz}$	2	5	2	8	5	8	9	11	nH

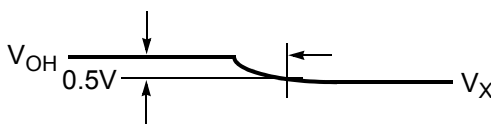
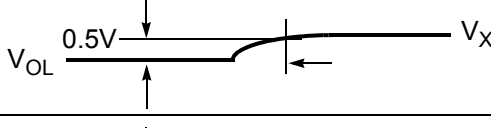
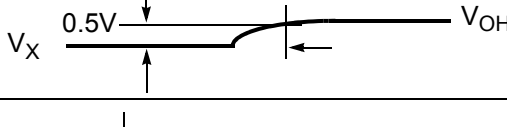
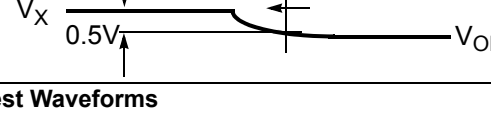
Capacitance^[5]

Parameter	Description	Test Conditions	Max.	Unit
$C_{I/O}$	Input/Output Capacitance	$V_{IN} = 3.3V$ at $f = 1\text{ MHz}$ at $T_A = 25^\circ C$	8	pF
C_{CLK}	Clock Signal Capacitance	$V_{IN} = 3.3V$ at $f = 1\text{ MHz}$ at $T_A = 25^\circ C$	12	pF
C_{DP}	Dual Functional Pins ^[9]	$V_{IN} = 3.3V$ at $f = 1\text{ MHz}$ at $T_A = 25^\circ C$	16	pF

Endurance Characteristics^[5]

Parameter	Description	Test Conditions	Min.	Typ.	Unit
N	Minimum Reprogramming Cycles	Normal Programming Conditions ^[2]	1,000	10,000	Cycles

AC Characteristics
5.0V AC Test Loads and Waveforms

3.3V AC Test Loads and Waveforms


Parameter ^[11]	V _X	Output Waveform—Measurement Level
t _{ER} (-)	1.5V	
t _{ER} (+)	2.6V	
t _{EA} (+)	1.5V	
t _{EA} (-)	V _{the}	

(d) Test Waveforms

Switching Characteristics Over the Operating Range ^[12]

Parameter	Description	Unit
Combinatorial Mode Parameters		
t _{PD} ^[13, 14, 15]	Input to Combinatorial Output	ns
t _{PDL} ^[13, 14, 15]	Input to Output Through Transparent Input or Output Latch	ns
t _{PDLL} ^[13, 14, 15]	Input to Output Through Transparent Input and Output Latches	ns
t _{EA} ^[13, 14, 15]	Input to Output Enable	ns
t _{ER} ^[11, 13]	Input to Output Disable	ns
Input Register Parameters		
t _{WL}	Clock or Latch Enable Input LOW Time ^[8]	ns
t _{WH}	Clock or Latch Enable Input HIGH Time ^[8]	ns
t _{IS}	Input Register or Latch Set-up Time	ns
t _{IH}	Input Register or Latch Hold Time	ns
t _{CO} ^[13, 14, 15]	Input Register Clock or Latch Enable to Combinatorial Output	ns
t _{COL} ^[13, 14, 15]	Input Register Clock or Latch Enable to Output Through Transparent Output Latch	ns
Synchronous Clocking Parameters		
t _{CO} ^[14, 15]	Synchronous Clock (CLK ₀ , CLK ₁ , CLK ₂ , or CLK ₃) or Latch Enable to Output	ns
t _S ^[13]	Set-Up Time from Input to Sync. Clk (CLK ₀ , CLK ₁ , CLK ₂ , or CLK ₃) or Latch Enable	ns
t _H	Register or Latch Data Hold Time	ns
t _{CO2} ^[13, 14, 15]	Output Synchronous Clock (CLK ₀ , CLK ₁ , CLK ₂ , or CLK ₃) or Latch Enable to Combinatorial Output Delay (Through Logic Array)	ns
t _{SCS} ^[13]	Output Synchronous Clock (CLK ₀ , CLK ₁ , CLK ₂ , or CLK ₃) or Latch Enable to Output Synchronous Clock (CLK ₀ , CLK ₁ , CLK ₂ , or CLK ₃) or Latch Enable (Through Logic Array)	ns
t _{SL} ^[13]	Set-Up Time from Input Through Transparent Latch to Output Register Synchronous Clock (CLK ₀ , CLK ₁ , CLK ₂ , or CLK ₃) or Latch Enable	ns
t _{HL}	Hold Time for Input Through Transparent Latch from Output Register Synchronous Clock (CLK ₀ , CLK ₁ , CLK ₂ , or CLK ₃) or Latch Enable	ns

Notes:

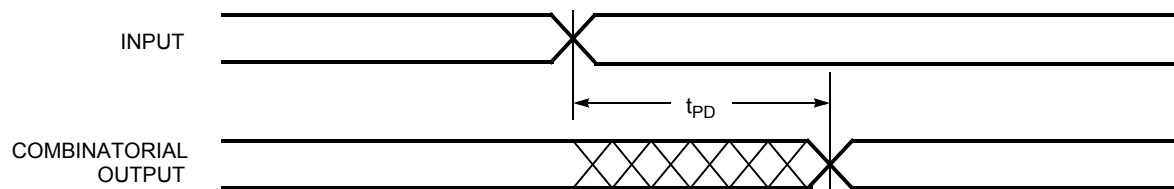
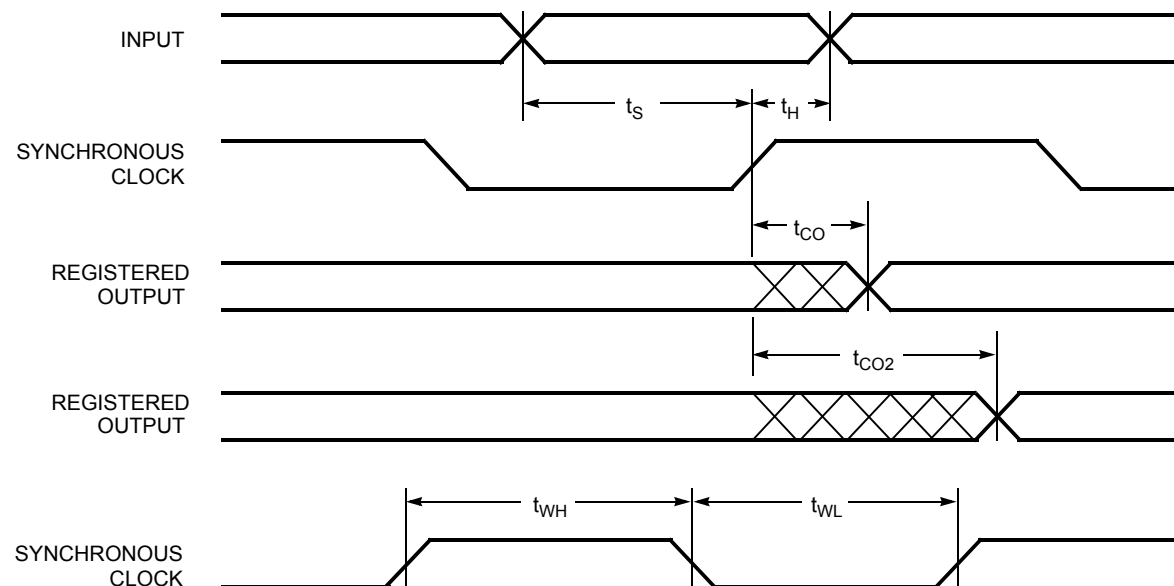
11. t_{ER} measured with 5-pF AC Test Load and t_{EA} measured with 35-pF AC Test Load.
12. All AC parameters are measured with two outputs switching and 35-pF AC Test Load.
13. Logic Blocks operating in Low-Power Mode, add t_{LP} to this spec.
14. Outputs using Slow Output Slew Rate, add t_{SLEW} to this spec.
15. When V_{CCO} = 3.3V, add t_{3.3IO} to this spec.

Switching Characteristics Over the Operating Range (continued)^[12]

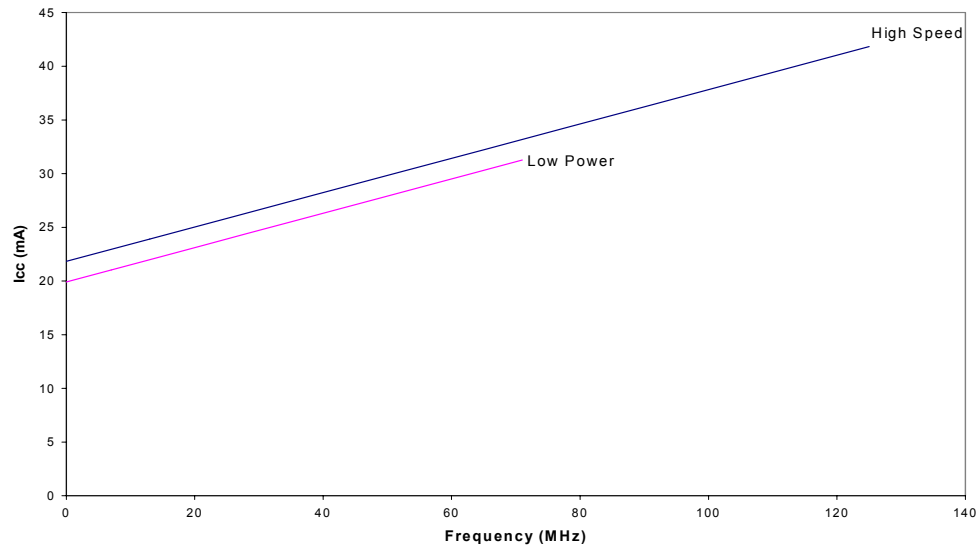
Parameter	Description	Unit
Product Term Clocking Parameters		
$t_{COPT}^{[13, 14, 15]}$	Product Term Clock or Latch Enable (PTCLK) to Output	ns
t_{SPT}	Set-Up Time from Input to Product Term Clock or Latch Enable (PTCLK)	ns
t_{HPT}	Register or Latch Data Hold Time	ns
$t_{ISPT}^{[13]}$	Set-Up Time for Buried Register used as an Input Register from Input to Product Term Clock or Latch Enable (PTCLK)	ns
t_{IHPT}	Buried Register Used as an Input Register or Latch Data Hold Time	ns
$t_{CO2PT}^{[13, 14, 15]}$	Product Term Clock or Latch Enable (PTCLK) to Output Delay (Through Logic Array)	ns
Pipelined Mode Parameters		
$t_{ICS}^{[13]}$	Input Register Synchronous Clock (CLK ₀ , CLK ₁ , CLK ₂ , or CLK ₃) to Output Register Synchronous Clock (CLK ₀ , CLK ₁ , CLK ₂ , or CLK ₃)	ns
Operating Frequency Parameters		
f_{MAX1}	Maximum Frequency with Internal Feedback (Lesser of $1/t_{SCS}$, $1/(t_S + t_H)$, or $1/t_{CO}$) ^[5]	MHz
f_{MAX2}	Maximum Frequency Data Path in Output Registered/Latched Mode (Lesser of $1/(t_{WL} + t_{WH})$, $1/(t_S + t_H)$, or $1/t_{CO}$) ^[5]	MHz
f_{MAX3}	Maximum Frequency with External Feedback (Lesser of $1/(t_{CO} + t_S)$ or $1/(t_{WL} + t_{WH})$) ^[5]	MHz
f_{MAX4}	Maximum Frequency in Pipelined Mode (Lesser of $1/(t_{CO} + t_{IS})$, $1/t_{ICS}$, $1/(t_{WL} + t_{WH})$, $1/(t_{IS} + t_{IH})$, or $1/t_{SCS}$) ^[5]	MHz
Reset/Preset Parameters		
t_{RW}	Asynchronous Reset Width ^[5]	ns
$t_{RR}^{[13]}$	Asynchronous Reset Recovery Time ^[5]	ns
$t_{RO}^{[13, 14, 15]}$	Asynchronous Reset to Output	ns
t_{PW}	Asynchronous Preset Width ^[5]	ns
$t_{PR}^{[13]}$	Asynchronous Preset Recovery Time ^[5]	ns
$t_{PO}^{[13, 14, 15]}$	Asynchronous Preset to Output	ns
User Option Parameters		
t_{LP}	Low Power Adder	ns
t_{SLEW}	Slow Output Slew Rate Adder	ns
$t_{3.3IO}$	3.3V I/O Mode Timing Adder ^[5]	ns
JTAG Timing Parameters		
$t_{S JTAG}$	Set-up Time from TDI and TMS to TCK ^[5]	ns
$t_{H JTAG}$	Hold Time on TDI and TMS ^[5]	ns
$t_{CO JTAG}$	Falling Edge of TCK to TDO ^[5]	ns
f_{JTAG}	Maximum JTAG Tap Controller Frequency ^[5]	ns

Switching Characteristics Over the Operating Range (continued)^[12]

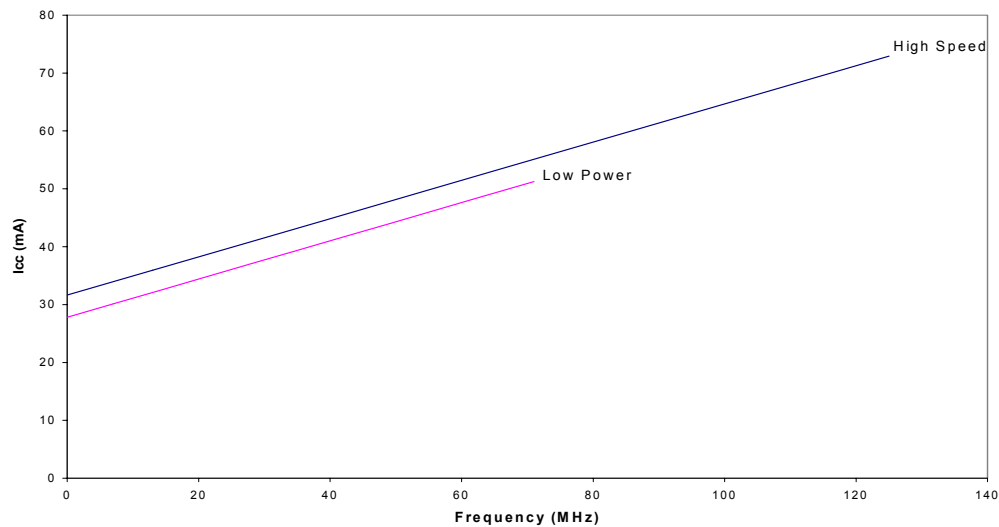
Parameter	200 MHz		167 MHz		154 MHz		143 MHz		125 MHz		100 MHz		83 MHz		66 MHz		Unit
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t_{RO} ^[13, 14, 15]		12		13		13		14		15		18		21		26	ns
t_{PW}	8		8		8		8		10		12		15		20		ns
t_{PR} ^[13]	10		10		10		10		12		14		17		22		ns
t_{PO} ^[13, 14, 15]		12		13		13		14		15		18		21		26	ns
User Option Parameters																	
t_{LP}		2.5		2.5		2.5		2.5		2.5		2.5		2.5		2.5	ns
t_{SLEW}		3		3		3		3		3		3		3		3	ns
$t_{3.3IO}$ ^[19]		0.3		0.3		0.3		0.3		0.3		0.3		0.3		0.3	ns
JTAG Timing Parameters																	
$t_{S\ JTAG}$	0		0		0		0		0		0		0		0		ns
$t_{H\ JTAG}$	20		20		20		20		20		20		20		20		ns
$t_{CO\ JTAG}$		20		20		20		20		20		20		20		20	ns
f_{JTAG}		20		20		20		20		20		20		20		20	MHz

Switching Waveforms
Combinatorial Output

Registered Output with Synchronous Clocking

Note:

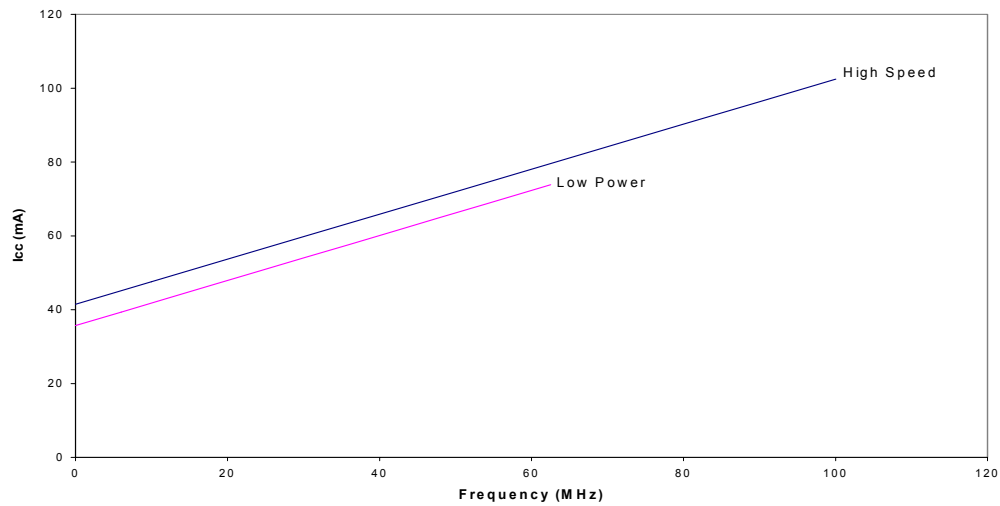
19. Only applicable to the 5V devices.

Typical 3.3V Power Consumption (continued)
CY37064V


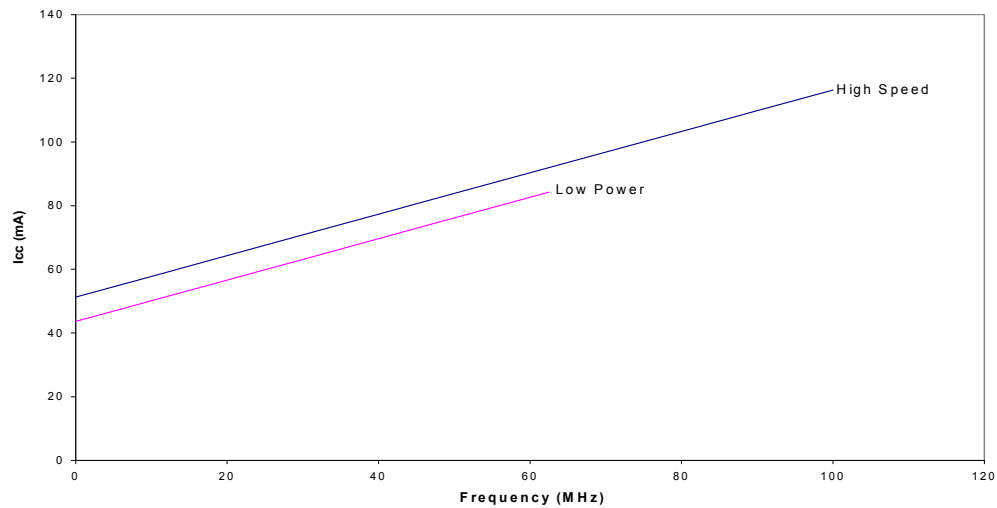
The typical pattern is a 16-bit up counter, per logic block, with outputs disabled.
 $V_{CC} = 3.3V$, $T_A = \text{Room Temperature}$

CY37128V


The typical pattern is a 16-bit up counter, per logic block, with outputs disabled.
 $V_{CC} = 3.3V$, $T_A = \text{Room Temperature}$

Typical 3.3V Power Consumption (continued)
CY37192V


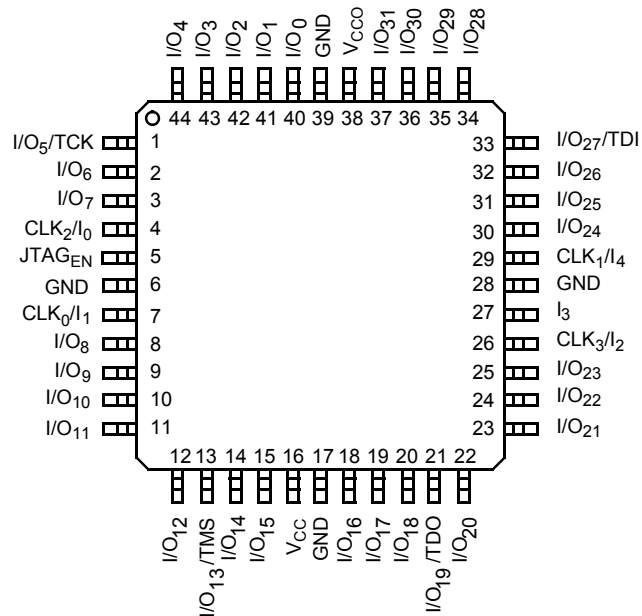
The typical pattern is a 16-bit up counter, per logic block, with outputs disabled.
 $V_{CC} = 3.3V$, $T_A = \text{Room Temperature}$

CY37256V


The typical pattern is a 16-bit up counter, per logic block, with outputs disabled.
 $V_{CC} = 3.3V$, $T_A = \text{Room Temperature}$

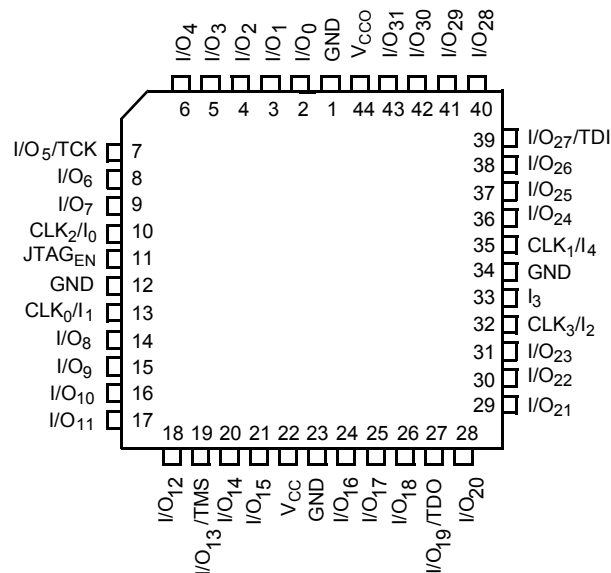
44-pin TQFP (A44)

Top View



44-pin PLCC (J67) / CLCC (Y67)

Top View

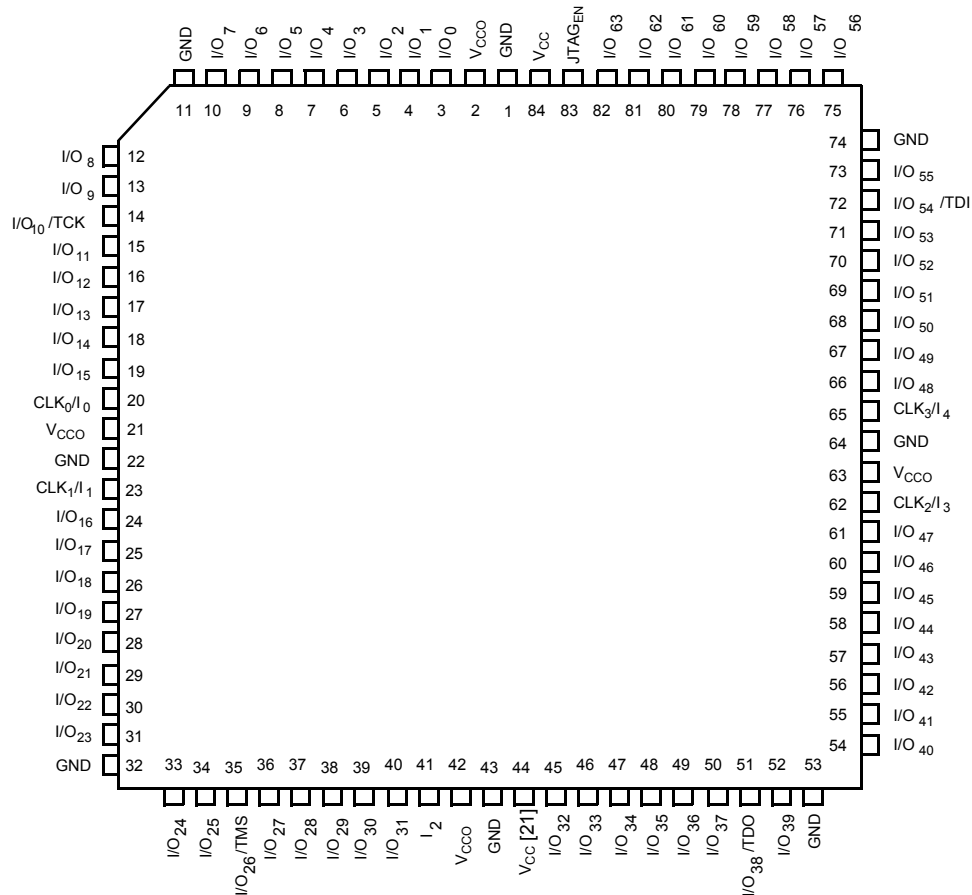


Pin Configurations^[20] (continued)
48-ball Fine-Pitch BGA (BA50)
Top View

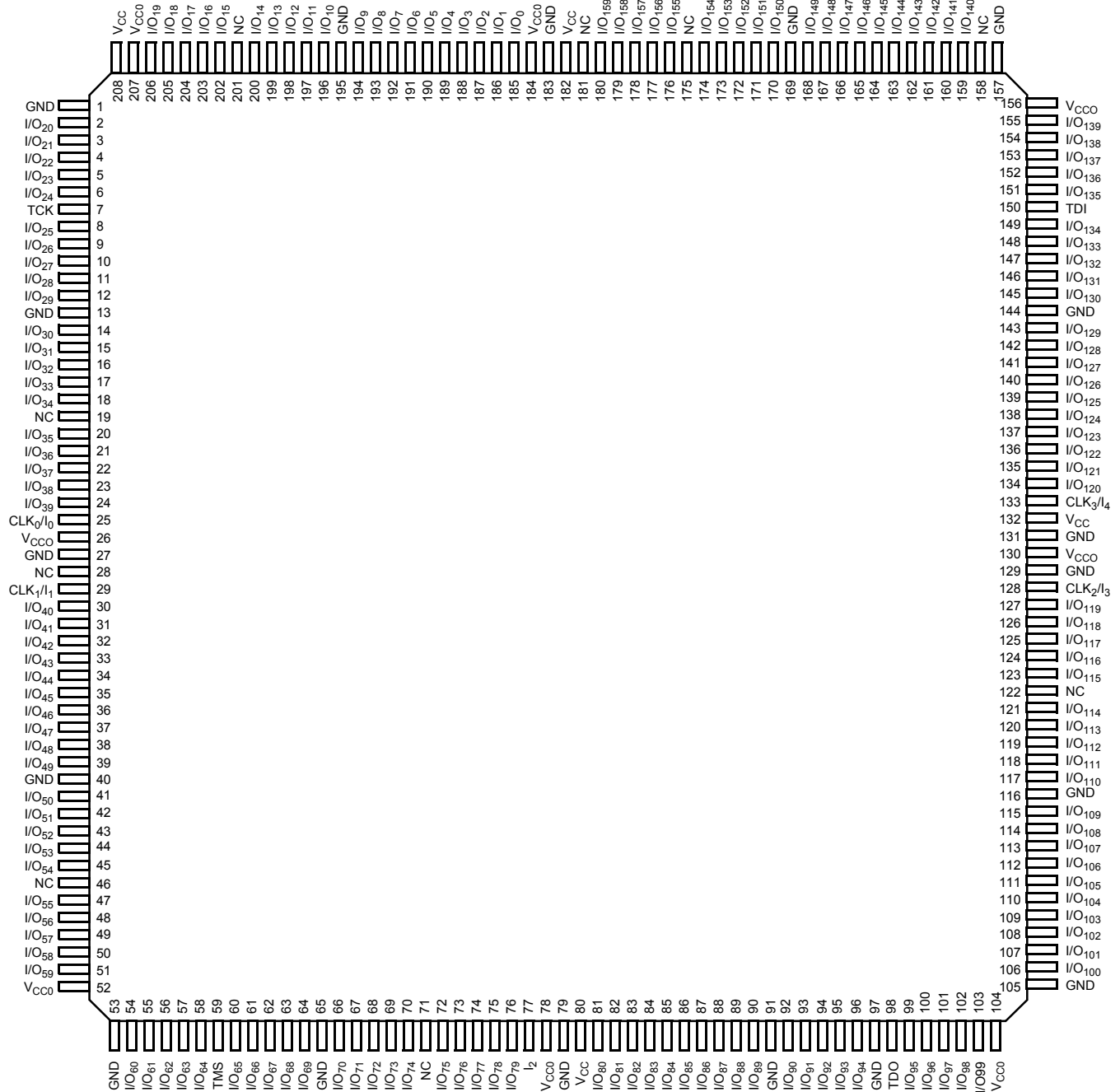
	1	2	3	4	5	6	7	8
A	I/O ₅ TCK	V _{CC}	I/O ₃	I/O ₁	I/O ₃₁	I/O ₃₀	V _{CC}	I/O ₂₇ TDI
B	V _{CC}	I/O ₄	I/O ₂	I/O ₀	I/O ₂₉	I/O ₂₈	I/O ₂₆	CLK ₁ /I ₄
C	CLK ₂ /I ₀	I/O ₇	I/O ₆	GND	GND	I/O ₂₅	I/O ₂₄	I ₃
D	JTAG _{EN}	I/O ₈	I/O ₉	GND	GND	I/O ₂₂	I/O ₂₃	CLK ₃ /I ₂
E	CLK ₀ /I ₁	I/O ₁₂	I/O ₁₁	I/O ₁₀	I/O ₁₆	I/O ₂₀	I/O ₂₁	V _{CC}
F	I/O ₁₃ TMS	V _{CC}	I/O ₁₄	I/O ₁₅	I/O ₁₇	I/O ₁₈	V _{CC}	I/O ₁₉ TDO

Note:

20. For 3.3V versions (Ultra37000V), V_{CCO} = V_{CC}.

84-lead PLCC (J83) / CLCC (Y84)
Top View

Note:

21. This pin is a N/C, but Cypress recommends that you connect it to V_{CC} to ensure future compatibility.

Pin Configurations^[20] (continued)
**208-Lead PQFP (N208) / CQFP (U208)
Top View**


Pin Configurations^[20] (continued)
256-Ball Fine-Pitch BGA (BB256)
Top View

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
A	GND	GND	I/O ₂₆	I/O ₂₄	I/O ₂₀	V _{CC}	I/O ₁₁	GND	GND	I/O ₁₈₆	V _{CC}	I/O ₁₇₇	I/O ₁₇₂	I/O ₁₆₇	GND	GND
B	GND	I/O ₂₇	I/O ₂₅	I/O ₂₃	I/O ₁₉	I/O ₁₅	I/O ₁₀	GND	GND	I/O ₁₈₅	I/O ₁₈₁	I/O ₁₇₆	I/O ₁₇₁	I/O ₁₆₆	I/O ₁₆₅	GND
C	I/O ₂₉	I/O ₂₈	NC	I/O ₂₂	I/O ₁₈	I/O ₁₄	I/O ₉	I/O ₄	I/O ₁₉₁	I/O ₁₈₄	I/O ₁₈₀	I/O ₁₇₅	I/O ₁₇₀	NC	I/O ₁₆₃	I/O ₁₆₄
D	I/O ₃₂	I/O ₃₁	I/O ₃₀	NC	I/O ₁₇	I/O ₁₃	I/O ₈	I/O ₃	I/O ₁₉₀	I/O ₁₈₃	I/O ₁₇₉	I/O ₁₇₄	I/O ₁₆₉	I/O ₁₆₀	I/O ₁₆₁	I/O ₁₆₂
E	I/O ₃₅	I/O ₃₄	I/O ₃₃	I/O ₂₁	I/O ₁₆	I/O ₁₂	I/O ₇	I/O ₂	I/O ₁₈₉	V _{CC}	I/O ₁₇₈	I/O ₁₇₃	I/O ₁₆₈	I/O ₁₅₇	I/O ₁₅₈	I/O ₁₅₉
F	V _{CC}	I/O ₃₈	I/O ₃₇	I/O ₃₆	TCK	V _{CC}	I/O ₆	I/O ₁	I/O ₁₈₈	I/O ₁₈₂	V _{CC}	TDI	I/O ₁₅₄	I/O ₁₅₅	I/O ₁₅₆	V _{CC}
G	I/O ₄₃	I/O ₄₂	I/O ₄₁	I/O ₄₀	V _{CC}	I/O ₃₉	I/O ₅	I/O ₀	I/O ₁₈₇	I/O ₁₄₈	I/O ₁₄₉	CLK ₃ /I ₄	I/O ₁₅₀	I/O ₁₅₁	I/O ₁₅₂	I/O ₁₅₃
H	GND	GND	I/O ₄₇	I/O ₄₆	CLK ₀ /I ₀	I/O ₄₅	I/O ₄₄	GND	GND	I/O ₁₄₄	I/O ₁₄₅	CLK ₂ /I ₃	I/O ₁₄₆	I/O ₁₄₇	GND	GND
J	GND	GND	I/O ₅₁	I/O ₅₀	NC	I/O ₄₉	I/O ₄₈	GND	GND	I/O ₁₄₀	I/O ₁₄₁	I ₂	I/O ₁₄₂	I/O ₁₄₃	GND	GND
K	I/O ₅₇	I/O ₅₆	I/O ₅₅	I/O ₅₄	CLK ₁ /I ₁	I/O ₅₃	I/O ₅₂	I/O ₉₁	I/O ₉₆	I/O ₁₀₁	I/O ₁₃₅	V _{CC}	I/O ₁₃₆	I/O ₁₃₇	I/O ₁₃₈	I/O ₁₃₉
L	V _{CC}	I/O ₆₀	I/O ₅₉	I/O ₅₈	TMS	V _{CC}	I/O ₈₆	I/O ₉₂	I/O ₉₇	I/O ₁₀₂	V _{CC}	TDO	I/O ₁₃₂	I/O ₁₃₃	I/O ₁₃₄	V _{CC}
M	I/O ₆₃	I/O ₆₂	I/O ₆₁	I/O ₇₂	I/O ₇₇	I/O ₈₂	V _{CC}	I/O ₉₃	I/O ₉₈	I/O ₁₀₃	I/O ₁₀₈	I/O ₁₁₂	I/O ₁₁₇	I/O ₁₂₉	I/O ₁₃₀	I/O ₁₃₁
N	I/O ₆₆	I/O ₆₅	I/O ₆₄	I/O ₇₃	I/O ₇₈	I/O ₈₃	I/O ₈₇	I/O ₉₄	I/O ₉₉	I/O ₁₀₄	I/O ₁₀₉	I/O ₁₁₃	NC	I/O ₁₂₆	I/O ₁₂₇	I/O ₁₂₈
P	I/O ₆₈	I/O ₆₇	NC	I/O ₇₄	I/O ₇₉	I/O ₈₄	I/O ₈₈	I/O ₉₅	I/O ₁₀₀	I/O ₁₀₅	I/O ₁₁₀	I/O ₁₁₄	I/O ₁₁₈	NC	I/O ₁₂₄	I/O ₁₂₅
R	GND	I/O ₆₉	I/O ₇₀	I/O ₇₅	I/O ₈₀	I/O ₈₅	I/O ₈₉	GND	GND	I/O ₁₀₆	I/O ₁₁₁	I/O ₁₁₅	I/O ₁₁₉	I/O ₁₂₁	I/O ₁₂₃	GND
T	GND	GND	I/O ₇₁	I/O ₇₆	I/O ₈₁	V _{CC}	I/O ₉₀	GND	GND	I/O ₁₀₇	V _{CC}	I/O ₁₁₆	I/O ₁₂₀	I/O ₁₂₂	GND	GND



Pin Configurations^[20] (continued)

Top View

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5.0V Ordering Information (continued)

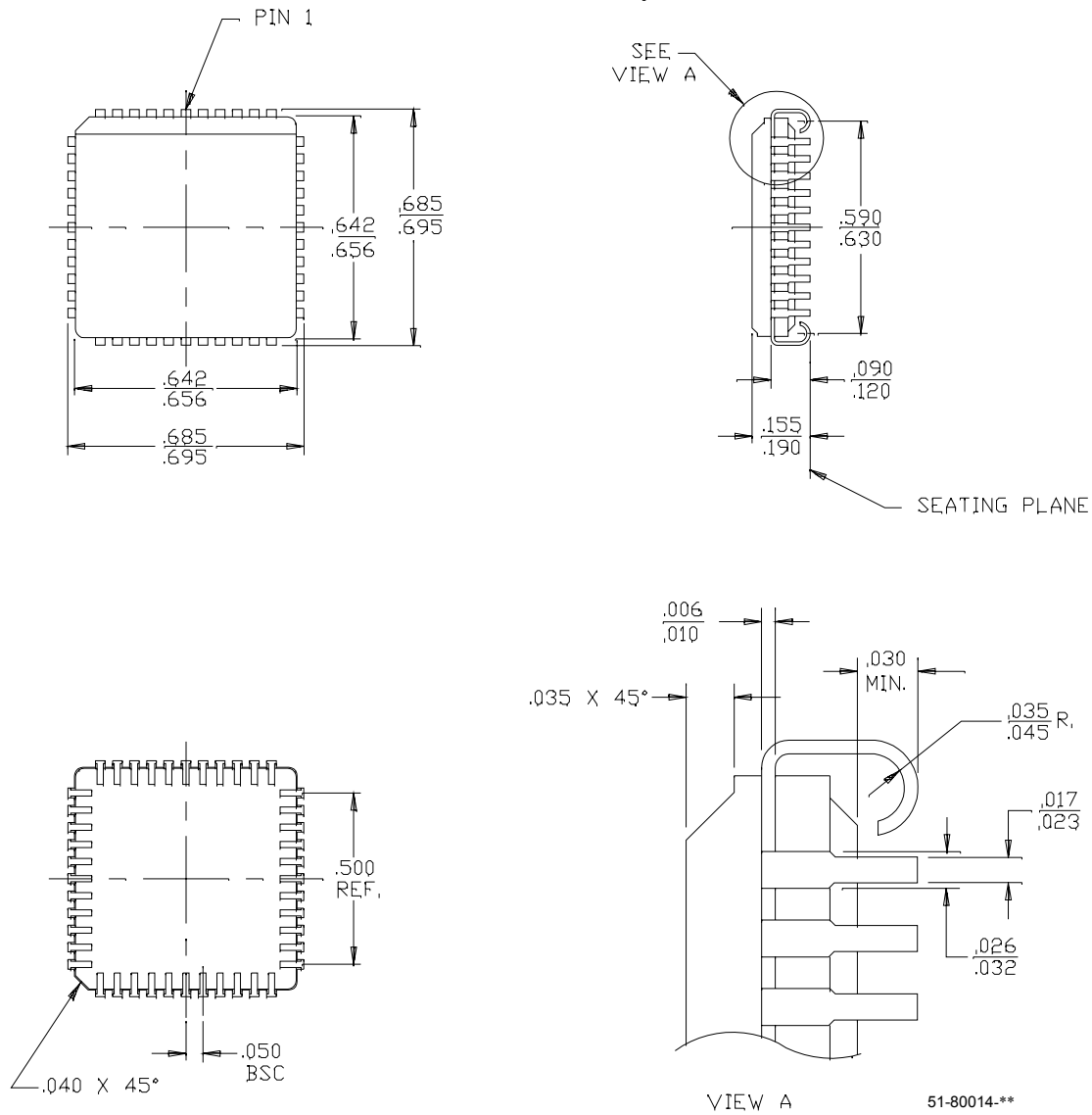
Macrocells	Speed (MHz)	Ordering Code	Package Name	Package Type	Operating Range
128	167	CY37128P84-167JC	J83	84-Lead Plastic Leaded Chip Carrier	Commercial
		CY37128P84-167JXC	J83	84-Lead Lead Free Plastic Leaded Chip Carrier	
		CY37128P100-167AC	A100	100-Lead Thin Quad Flat Pack	
		CY37128P100-167AXC	A100	100-Lead Lead Free Thin Quad Flat Pack	
		CY37128P160-167AC	A160	160-Lead Thin Quad Flat Pack	
		CY37128P160-167AXC	A160	160-Lead Lead Free Thin Quad Flat Pack	
	125	CY37128P84-125JC	J83	84-Lead Plastic Leaded Chip Carrier	Commercial
		CY37128P84-125JXC	J83	84-Lead Lead Free Plastic Leaded Chip Carrier	
		CY37128P100-125AC	A100	100-Lead Thin Quad Flat Pack	
		CY37128P100-125AXC	A100	100-Lead Lead Free Thin Quad Flat Pack	
		CY37128P160-125AC	A160	160-Lead Thin Quad Flat Pack	
		CY37128P160-125AXC	A160	160-Lead Lead Free Thin Quad Flat Pack	
		CY37128P84-125JI	J83	84-Lead Plastic Leaded Chip Carrier	Industrial
		CY37128P84-125JXI	J83	84-Lead Lead Free Plastic Leaded Chip Carrier	
		CY37128P100-125AI	A100	100-Lead Thin Quad Flat Pack	
		CY37128P100-125AXI	A100	100-Lead Lead Free Thin Quad Flat Pack	
		CY37128P160-125AI	A160	160-Lead Thin Quad Flat Pack	
		CY37128P160-125AXI	A160	160-Lead Lead Free Thin Quad Flat Pack	
		5962-9952102QYA	Y84	84-Lead Ceramic Leaded Chip Carrier	Military
	100	CY37128P84-100JC	J83	84-Lead Plastic Leaded Chip Carrier	Commercial
		CY37128P84-100JXC	J83	84-Lead Lead Free Plastic Leaded Chip Carrier	
		CY37128P100-100AC	A100	100-Lead Thin Quad Flat Pack	
		CY37128P100-100AXC	A100	100-Lead Lead Free Thin Quad Flat Pack	
		CY37128P160-100AC	A160	160-Lead Thin Quad Flat Pack	
		CY37128P160-100AXC	A160	160-Lead Lead Free Thin Quad Flat Pack	
		CY37128P84-100JI	J83	84-Lead Plastic Leaded Chip Carrier	Industrial
		CY37128P100-100AI	A100	100-Lead Thin Quad Flat Pack	
		CY37128P100-100AXI	A100	100-Lead Lead Free Thin Quad Flat Pack	
		CY37128P160-100AI	A160	160-Lead Thin Quad Flat Pack	
		5962-9952101QYA	Y84	84-Lead Ceramic Leaded Chip Carrier	Military
192	154	CY37192P160-154AC	A160	160-Lead Thin Quad Flat Pack	Commercial
		CY37192P160-154AXC	A160	160-Lead Lead Free Thin Quad Flat Pack	
	125	CY37192P160-125AC	A160	160-Lead Thin Quad Flat Pack	Commercial
		CY37192P160-125AXC	A160	160-Lead Lead Free Thin Quad Flat Pack	
		CY37192P160-125AI	A160	160-Lead Thin Quad Flat Pack	Industrial
		CY37192P160-125AXI	A160	160-Lead Lead Free Thin Quad Flat Pack	
	83	CY37192P160-83AC	A160	160-Lead Thin Quad Flat Pack	Commercial
		CY37192P160-83AXC	A160	160-Lead Lead Free Thin Quad Flat Pack	
		CY37192P160-83AI	A160	160-Lead Thin Quad Flat Pack	Industrial
		CY37192P160-83AXI	A160	160-Lead Lead Free Thin Quad Flat Pack	

5.0V Ordering Information (continued)

Macrocells	Speed (MHz)	Ordering Code	Package Name	Package Type	Operating Range
256	154	CY37256P160-154AC	A160	160-Lead Thin Quad Flat Pack	Commercial
		CY37256P160-154AXC	A160	160-Lead Lead Free Thin Quad Flat Pack	
		CY37256P208-154NC	N208	208-Lead Plastic Quad Flat Pack	
		CY37256P256-154BGC	BG292	292-Ball Plastic Ball Grid Array	
	125	CY37256P160-125AC	A160	160-Lead Thin Quad Flat Pack	Commercial
		CY37256P160-125AXC	A160	160-Lead Lead Free Thin Quad Flat Pack	
		CY37256P208-125NC	N208	208-Lead Plastic Quad Flat Pack	
		CY37256P256-125BGC	BG292	292-Ball Plastic Ball Grid Array	
		CY37256P160-125AI	A160	160-Lead Thin Quad Flat Pack	Industrial
		CY37256P160-125AXI	A160	160-Lead Lead Free Thin Quad Flat Pack	
		CY37256P208-125NI	N208	208-Lead Plastic Quad Flat Pack	
		CY37256P256-125BGI	BG292	292-Ball Plastic Ball Grid Array	
		5962-9952302QZC	U162	160-Lead Ceramic Quad Flat Pack	Military
	83	CY37256P160-83AC	A160	160-Lead Thin Quad Flat Pack	Commercial
		CY37256P160-83AXC	A160	160-Lead Lead Free Thin Quad Flat Pack	
		CY37256P208-83NC	N208	208-Lead Plastic Quad Flat Pack	
		CY37256P256-83BGC	BG292	292-Ball Plastic Ball Grid Array	
		CY37256P160-83AI	A160	160-Lead Thin Quad Flat Pack	Industrial
		CY37256P160-83AXI	A160	160-Lead Lead Free Thin Quad Flat Pack	
		CY37256P208-83NI	N208	208-Lead Plastic Quad Flat Pack	
		CY37256P256-83BGI	BG292	292-Ball Plastic Ball Grid Array	
		5962-9952301QZC	U162	160-Lead Ceramic Quad Flat Pack	Military
384	125	CY37384P208-125NC	N208	208-Lead Plastic Quad Flat Pack	Commercial
		CY37384P256-125BGC	BG292	292-Ball Plastic Ball Grid Array	
	83	CY37384P208-83NC	N208	208-Lead Plastic Quad Flat Pack	Commercial
		CY37384P256-83BGC	BG292	292-Ball Plastic Ball Grid Array	
		CY37384P208-83NI	N208	208-Lead Plastic Quad Flat Pack	Industrial
		CY37384P256-83BGI	BG292	292-Ball Plastic Ball Grid Array	

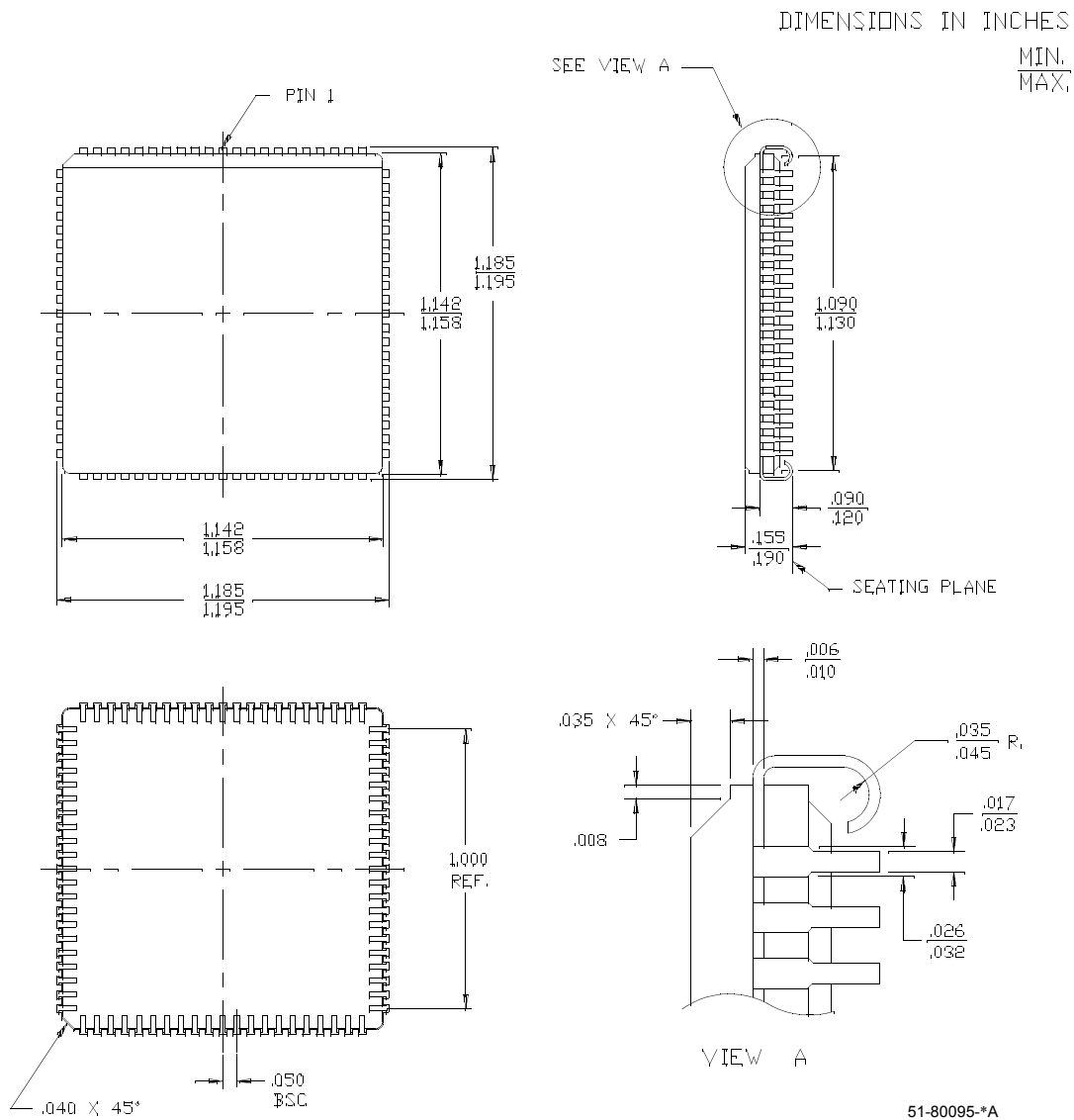
Package Diagrams (continued)

44-Lead Ceramic Leaded Chip Carrier Y67



Package Diagrams (continued)

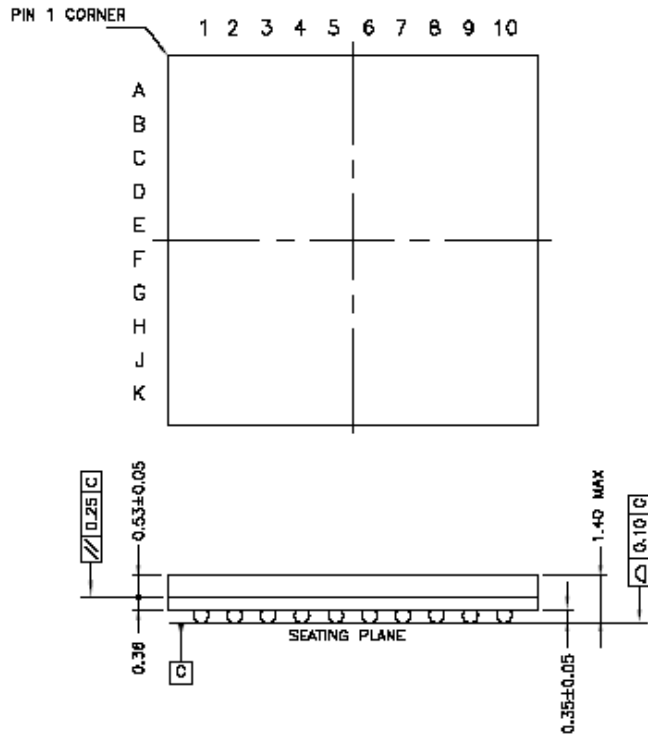
84-Lead Ceramic Leaded Chip Carrier Y84



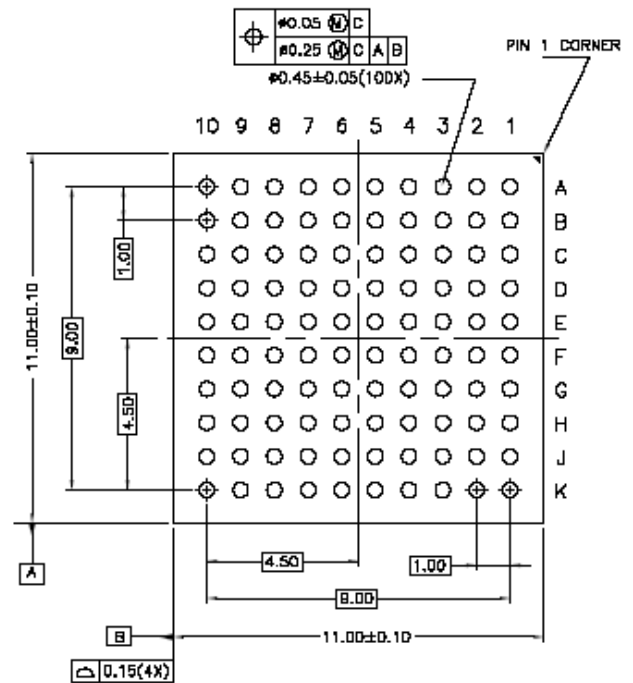
Package Diagrams (continued)

100-Ball Thin Ball Grid Array (11 x 11 x 1.4 mm) BB100

TOP VIEW



BOTTOM VIEW



51-85107-B

Addendum**3.3V Operating Range****(CY37064VP100-143AC, CY37064VP100-143BBC, CY37064VP44-143AC, CY37064VP48-143BAC)**

Range	Ambient Temperature ^[2]	Junction Temperature	V _{CC}
Commercial	0°C to +70°C	0°C to +90°C	3.3V ± 0.16V